

## FEATURES

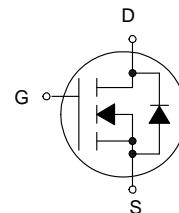
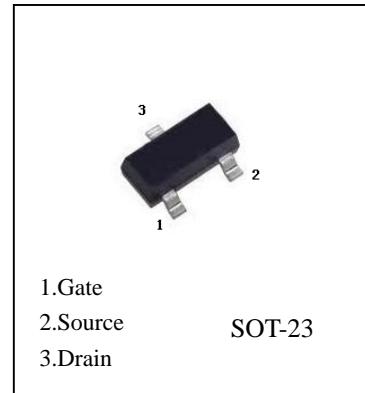
- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Fully Characterized Avalanche Voltage and Current
- Improved Shoot-Through FOM

Absolute Maximum Ratings (TA=25°C, unless otherwise noted)

Parameter	Symbol	Ratings	Units
Drain-Source Voltage	V <sub>DS</sub>	20	V
Gate-Source Voltage	V <sub>GS</sub>	±8	V
Drain Current (Continuous)	I <sub>D</sub>	2.4	A
Drain Current (Pulsed) <sup>1</sup>	I <sub>DM</sub>	8	A
Total Power Dissipation @TA=25°C	P <sub>D</sub>	0.9	W
Maximum Diode Forward Current	I <sub>S</sub>	1.6	A
Operating Junction and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55 to +150	°C
Thermal Resistance Junction to Ambient (PCB mounted) <sup>2</sup>	R <sub>JA</sub>	140	°C/W

1: Repetitive Rating: Pulse width limited by the maximum junction temperature. 2: 1-in2 2oz Cu PCB board

**SI2300**  
N-Channel MOSFET



Electrical Characteristics (TA=25°C, unless otherwise noted)

Symbol	Characteristic	Test Conditions	Min.	Typ.	Max.	Unit
<b>• Off Characteristics</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	20	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V	-	-	1	uA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±8V, V <sub>DS</sub> =0V	-	-	±100	nA
<b>• On Characteristics<sup>3</sup></b>						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	0.6	0.8	1.2	V
R <sub>DS(on)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =2.8A	-	40	60	m
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =2A	-	50	115	
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =3.6A	-	10	-	S
<b>• Dynamic Characteristics<sup>4</sup></b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =6V, V <sub>GS</sub> =0V, f=1MHz	-	426	-	PF
C <sub>oss</sub>	Output Capacitance		-	79.5	-	PF
C <sub>rss</sub>	Reverse Transfer Capacitance		-	56	-	PF

Electrical Characteristics (TA=25°C, unless otherwise noted)

• Switching Characteristics<sup>4</sup>

$Q_g$	Total Gate Charge	$V_{DS}=6V, I_D=2.8A, V_{GS}=4.5V$		3.73	-	nC
$Q_{gs}$	Gate-Source Charge		-	0.75	-	
$Q_{gd}$	Gate-Drain Charge		-	1.04	-	
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=6V, R_L=6\Omega, I_D=1A, V_{GEN}=4.5V, R_G=6\Omega$	-	5.9	-	nS
$t_r$	Turn-on Rise Time		-	7.45	-	
$t_{d(off)}$	Turn-off Delay Time		-	16	-	
$t_f$	Turn-off Fall Time		-	3.96	-	
• Drain-Source Diode Characteristics						
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS}=0V, I_S=-1.6A$	-		1.2	V

3 : Pulse Test : Pulse Width < 300μs, Duty Cycle < 2%. 4: Guaranteed by design, not subject to production testing

### SI2300 Typical Characteristics

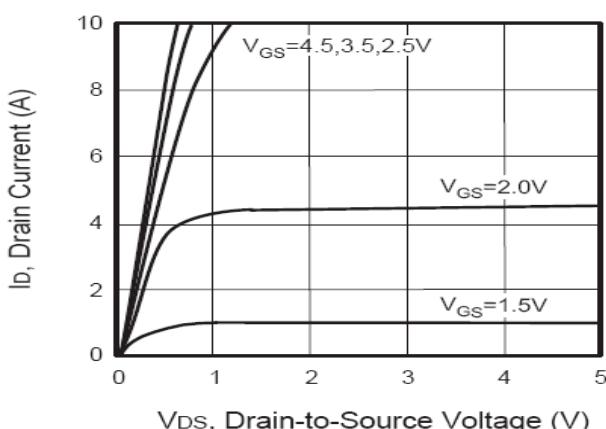


Figure 1. Output Characteristics

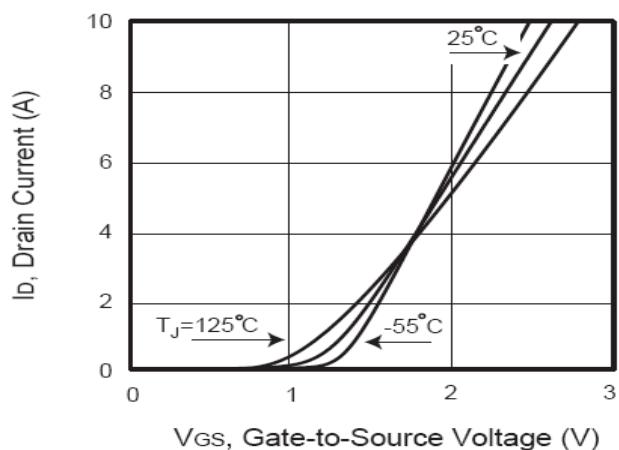
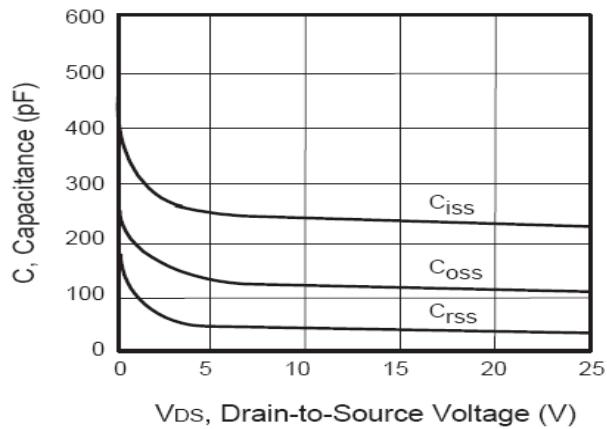
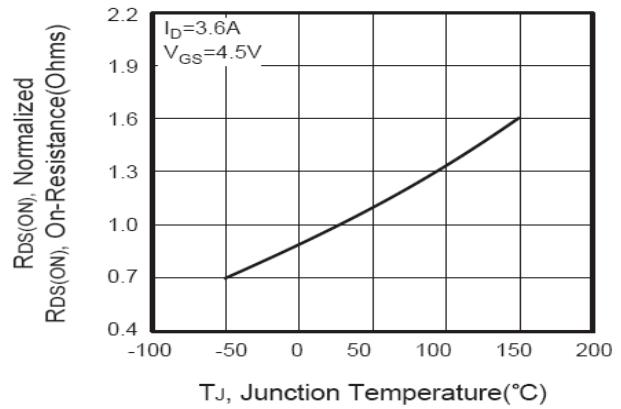
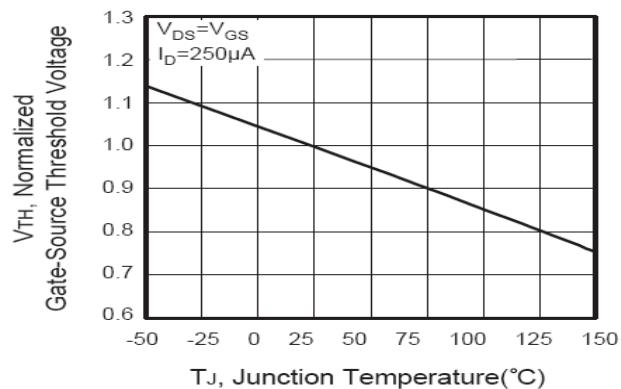
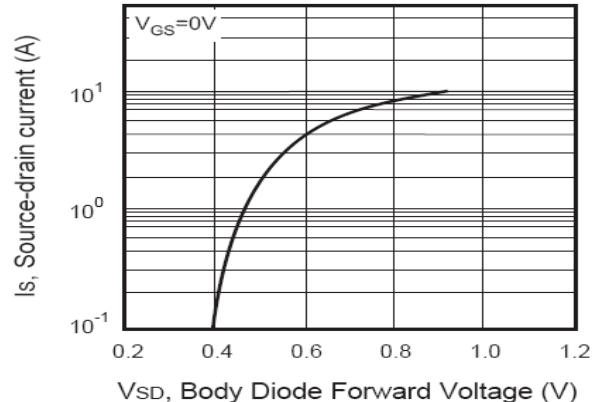


Figure 2. Transfer Characteristics

**SI2300 Typical Characteristics**

**Figure 3. Capacitance**

**Figure 4. On-Resistance Variation with Temperature**

**Figure 5. Gate Threshold Variation with Temperature**

**Figure 6. Body Diode Forward Voltage Variation with Source Current**